Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/700,168	GEDIK ET AL.	
Examiner	Art Unit	

3661

CUONG H. NGUYEN

SEARCHED						
Class	Subclass	Date	Examiner			
707	1,3	6/20/2007	CHN			
342	357.06					
455	456.1					
	41.2,458					
	141					
701	207,213	1	1			

INTERFERENCE SEARCHED						
Class	Subclass	Date		Examiner		
707	3,207,213	6/22/2007		CHN		
701	207					
342	357.06					
	G01C 21/00,26 G08G 1/127		/	V	/	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
WEST/DERWENT frwrd/bkwrd searches on closest references and allowable subject matter	6/22/2007	CHN		
Allowance conference w/ SPE	6/22/2007	CHN		
IEEE Xplore	6/22/2007	CHN		
Inventors'names search	6/22/2007	CHN		
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